



General Description

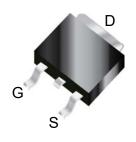
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

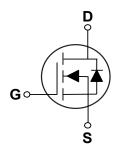
| BV _{DSS} | R _{DS(ON)} | Ι _D |
|-------------------|---------------------|----------------|
| 40 V | 4 mΩ | 85 A |

Features

- $\cdot R_{DS(ON)} \leq 4m\Omega@V_{GS} = 10V$
- Fast Switching
- · Green Device Available

TO-263 Pin Configuration





Applications

- · Synchronous Rectification
- · DC/DC Converter

| solute Maximum Ratings T _c =25°C unless otherwise noted | | | | | |
|--|---|------------|------|--|--|
| Symbol | Parameter | Rating | Unit | | |
| V_{DS} | Drain-Source Voltage | 40 | V | | |
| V_{GS} | Gate-Source Voltage | ±20 | V | | |
| I _D | Drain Current - Continuous (T _C =25°C) | 85 | Α | | |
| I _{DM} | Drain Current - Pulsed (NOTE 1) | 340 | Α | | |
| EAS | Single Pulse Avalanche Energy (NOTE 2) | 200 | mJ | | |
| IAS | Single Pulse Avalanche Current (NOTE 2) | 20 | Α | | |
| P_{D} | Power Dissipation (T _C =25°C) | 96.1 | W | | |
| T _J | Operating Junction Temperature Range | -55 to 150 | °C | | |
| T _{STG} | Storage Temperature Range | -55 to 150 | °C | | |
| Marking Code | | ND4P0 | | | |

| Thermal Characteristics | | | | |
|-------------------------|-------------------------------------|--------|------|--|
| Symbol | Parameter | Rating | Unit | |
| $R_{	heta JC}$ | Thermal Resistance Junction to Case | 1.3 | °C/W | |





Electrical Characteristics (T_J=25°C, unless otherwise noted)

Off Characteristics

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|-------------------|--------------------------------|-------------------------------|------|------|------|------|
| BV _{DSS} | Drain-Source Breakdown Voltage | V_{GS} =0V , I_D =250uA | 40 | | | V |
| I _{DSS} | Drain-Source Leakage Current | V_{DS} =32V , V_{GS} =0V | | | 1 | uA |
| I _{GSS} | Gate-Source Leakage Current | V_{GS} =±20V , V_{DS} =0V | | | ±100 | nA |

On Characteristics

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|---------------------|-----------------------------------|-------------------------------|------|------|------|------|
| R _{DS(ON)} | Static Drain-Source On-Resistance | V_{GS} =10V , I_D =30A | | | 4 | mΩ |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}$, $I_D=250uA$ | 1.0 | | 3.0 | V |

Dynamic and switching Characteristics (NOTE 4)

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|------------------|------------------------------|--|------|------|------|------|
| Q_g | Total Gate Charge | | | 71 | | |
| Q_gs | Gate-Source Charge | V_{DS} =20V , V_{GS} =10V , I_{D} =40A | | 14 | | nC |
| Q_gd | Gate-Drain Charge | | | 13 | | i |
| $T_{d(on)}$ | Turn-On Delay Time | | | 15 | | |
| T_r | Rise Time | V_{DD} =20V , V_{GS} =10V , R_{G} =3 Ω , I_{D} =40A | | 60 | | nS |
| $T_{d(off)}$ | Turn-Off Delay Time | | | 97 | | 113 |
| T_f | Fall Time | | | 35.5 | | |
| C_{iss} | Input Capacitance | | | 4150 | | |
| C _{oss} | Output Capacitance | V _{DS} =20V , V _{GS} =0V , f=1MHz | | 400 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 378 | | |
| R_g | Gate Resistance | V_{GS} =0V , V_{DS} =0V , f=1MHz | | 2 | | Ω |

Drain-Source Diode Characteristics and Ratings

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|----------|---------------------------|--|------|------|------|------|
| Is | Continuous Source Current | V _G =V _D =0V , Force Current | | | 85 | Α |
| V_{SD} | Diode Forward Voltage | V _{GS} =0V , I _S =1A | | | 1 | V |

NOTES:

- ${\bf 1.}\ Repetitive\ Rating: Pulsed\ width\ limited\ by\ maximum\ junction\ temperature.$
- 2. V_{DD} =25V, V_{GS} =10V, L=1mH, I_{AS} =20A.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Guaranteed by design, not subject to production testing.



D2MND4P0



40V N-Channel MOSFETs

Characteristics Curves

FIG. 1-Drain Current

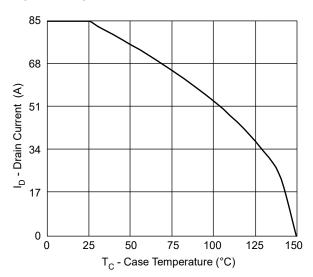


FIG. 2-Normalized $V_{GS(th)}$ vs T_J

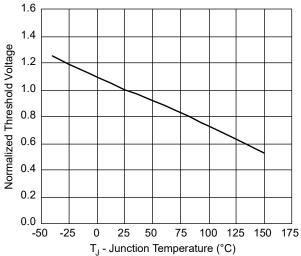


FIG. 2-Normalized $R_{DS(ON)}$ vs T_J

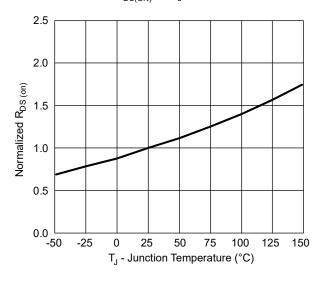


FIG. 4-Gate Charge Characteristics

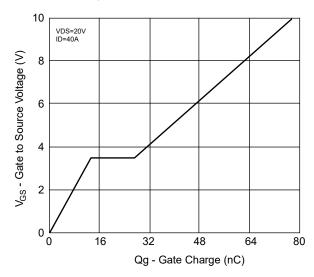


FIG. 5-Safe Operation Area

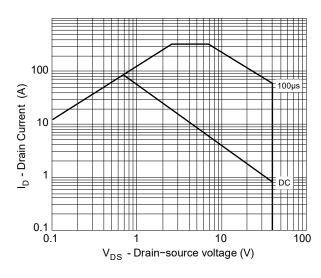
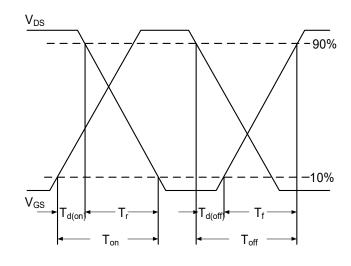


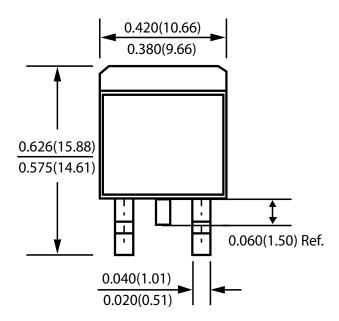
FIG. 6 - Switching Time Waveform

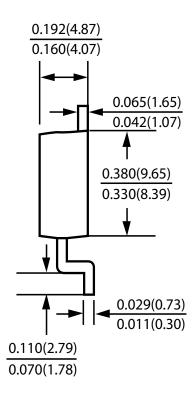






Package Outline Dimensions





TO-263Dimensions in inches and (millimeters)





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